

Evolutionary Value Added Measurement System

EVA100

Powerful Support for Characteristics Evaluation, Functional Evaluation, and Productivity Evaluation



In recent years the number of smart devices we use has increased significantly. The role of analog / sensor ICs has become critically important. More than ever, higher performance, tighter accuracy and longer reliability are required for these devices. To address these challenges measurement systems need to have many features while maintaining a very low test cost, and engineers tasked with developing test programs require very good coding skills plus in-depth operation knowledge of the test system.

Our new highly integrated measurement system "EVA100" is supporting Power Supplies, SMU(4 quadrant DC Signal Measurement Units), Pattern Generators, Arbitrary Waveform Generators, Digitizers and Oscilloscopes necessary for complete analog / mixed-signal device evaluation and measurement.

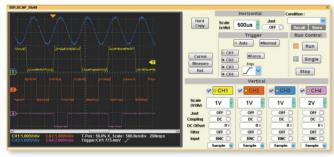
Our newly developed Software GUI is extremely intuitive, requiring only drag & drop operation, enabling engineers to create device focused measurement set ups in a very fast and simple manner. Automatic report functions dramatically improve the efficiency of desk work, providing clear documentation and data ready for publishing in device data sheets.

Main Functions

Characteristics Evaluation

4 channels high frequency sampling digitizer to observe and measure transient response waveforms or behavior of device under test(DUT).

Signal Capture module(SCAP)



Features

Our new measurement system EVA100 enables easy, rapid characterization, functional evaluation and mass production evaluations of low pin count analog(*1) and mixed signal(*2) devices.

(*1): DC-DC Converter or Voltage regulator ICs (*2): AD Converter DA Converter ICs

Small

All necessary functions are integrated into the compact body (363mm x 472mm x 205mm) which has VI sources (AVI, MVI), General Control Module(GCM) and Signal Capture(SCAP).

High Performance

The Event Master Sequencer (EMS) controls the hardware with high timing accuracy and high precision enabling superior repeatability. Analog VI source, General Control Module and Signal Capture instruments provide versatile and comprehensive measurement capability.

Intuitive

"No programming language environment" offers very intuitive operation for users, so that everyone from beginners to experts is able to use the system quickly. Automatic report generation tools reduce the need for additional desk work, improving the efficiency of evaluation and measurement tasks dramatically.

Scalable

Scalable architecture supports many scenarios from design to production for analog and mixed signal devices.

Supporting external instruments, customized measurement systems can also be created according to more specific requirements and needs.

Productivity

graphical data. Automatic

report generation frees users from taking notes

each time during debug

in formats such as CSV

allows, further analysis

and documentation to be performed seamlessly.

sessions in Exporting data,

The Test Conditions and Results for each measurement are reported in HTML format which can include

Documentation (Report Generator)

Functional Evaluation

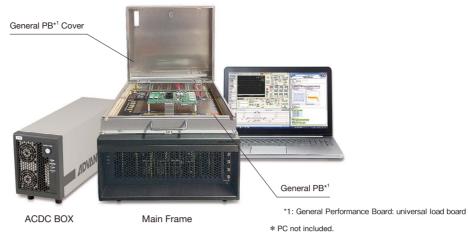
Sequence Editor makes it easy to synchronize multiple hardware channels based on how the user determines when events occur. The Sequence Editor also supports continuous measurement or conditional loop settings enabling greater control of automated measurements.

Synchronized Sequence Control (Sequence Editor)

I2C, SPI, and JTAG I/F are supported by protocol based control. By preparing the Register Map, we can use the register name for digital patterns instead of mnemonics so that Register Map gives you a clear overview for the digital pattern and improve the readability and efficiency of digital pattern debug.

Protocol Support (Register Map)

Hexadecimal 🛛 😣 Regis	ster Map Slave Addre	ss OxCO	Sett	ing 🕂 🗕			Condition :
T Shutdown INT_TEM						•	Recall Store
ommand Detail				Pin Condition	Signal Level	3.3V 💌	
VW Address Name	Function Name	Value		Channel Define	and the second second		Start
rite 💟 DVR	DVR		-	SCL CH1	DataRate	1kbps 💌	/ Stop
				SDA CH2	TimeOut	10m s	\bigcirc



* Image of measurement unit for reference purposes only.

Standard system set up

Function Module name		Description			
ore Module					
Synchronization	EMS	System Bus and Synchronization; External Instruments Control and Synchronization (Incl. Thermal Unit) 4ch: Utility Power Supply: +5V, +12V, +15V, -15V			
General Control	GCM	 8ch: I2C, SPI, JTAG and Custom Interface; 100Mbps Pattern Generator; Digital Function Test; 4 Quadrant Per Pin Parametric Measurement Unit 64ch: Relay Control bit 0 to 5V Time Measurement Unit (1ch): DC to 100MHz Frequency; TPD Tr / Tf; Period 			
easurement Module					
Multi Channel (6ch) Voltage/Current Source Measurement	AVI	 6ch: Voltage Source: 4.5 digits, +/- 64V or -32V to +96V; Resolution: 62.5μV to 4mV Current Source: +/-500mA at +/-2V to +/-8V Range, +/-200mA at +/-16V Range, +/-80mA at +/-32V to +/-64V Range, +/-30mA at -32V to +96V Range; Resolution: 0.25nA to 25μA Voltage Measurement: Max 5.5 digits Display; Min Resolution: 15.625μV Current Measurement: Max 500mA Display; Min Resolution: 62.5pA 4 Quadrant VI; Ramp / Program Generation; Parallel / Stack Connection; Digitizer; Arbitrary Waveform Generator 			
Middle Power (2ch) Voltage/Current Source Measurement	MVI	 2ch: Voltage Source: 4.5 digits, +/-128V; Min Resolution: 62.5μV Current Source: +/-5 A (Pulse); Min Resolution: 0.25 nA Voltage Measurement: Max 5.5 digits Display; Min Resolution: 15.625μV Current Measurement: Max 5A Display; Min Resolution: 62.5pA 4 Quadrant VI; Ramp / Program Generation; Parallel Connection; Digitizer; Arbitrary Waveform Generator 			
Pattern Generator (32ch)	DM	32ch: 100Mbps Pattern Generator; Digital Function Test; 4 Quadrant Per Pin Parametric Measurement Unit; Low Jitter Clock (8ch) Time Measurement Unit (4ch): DC to 100MHz Frequency; TPD Tr / Tf; Period			
Arbitrary Waveform Generator (4ch) Digitizer	LF	4ch: Arbitrary Waveform Generator: 200ksps/24bit, 80kHz Band Width Digitizer: 625ksps/24bit, 200kHz Band Width 4 Quadrant Per Pin Parametric Measurement Unit			
Oscilloscope (2Gsps)	SCAP	500MHz Band Width (PB Direct Input: 50 ohm), 300MHz Band Width (BNC Input: 1M ohm); 2Gsps (2ch) or 4ch 1Gsps (4ch); 8,000 Point per channel			
thers					
Recommended PC		2.2GHz, 64bit 4-Core Processor, Memory: 8GB, Display resolution: 1366x768, or better Interface: USB2.0x1, or better; ExpressCard/34 or ExpressCard/54			
Operation Software		Microsoft Windows* 7 (64bit) Service Pack 1			
vstem size					
Main Frame		363 mm (W) x 472 mm (D) x 205 mm (H) weight: Approximately 11kg (minimum configuration)			
ACDC BOX		140 mm (W) x 472 mm (D) x 205 mm (H)			

* Microsoft Windows is a registered trademark of Microsoft Corporation in the U.S. and other countries.

At a Glance

System package

	Module configuration *EMS (Event Master Sequencer) is included in standard configuration							
Model Number	GCM (<u>G</u> eneral <u>C</u> ontrol <u>M</u> odule)	AVI (<u>A</u> nalog <u>VI</u> Source)	MVI (<u>M</u> iddle Power <u>VI</u> Source)	SCAP (<u>S</u> ignal <u>Cap</u> ture Module)	DM (<u>D</u> igital <u>M</u> odule)	LF (Low Erequency AWG/DGT)		
EVA100-E1-A21	8ch	6ch	_	4ch	_	_		
EVA100-E1-A22	8ch	12ch	2ch	4ch	_	_		
EVA100-E1-A23	8ch	18ch	4ch	4ch	_	_		
EVA100-E1-A24	8ch	12ch	8ch	_	_	_		
EVA100-E1-A25	8ch	36ch	-	_	_	_		
EVA100-E1-M21	8ch	6ch	-	4ch	32ch	4ch		
EVA100-E1-M23	8ch	18ch	-	4ch	32ch	4ch		
EVA100-E1-M25	8ch	18ch	-	_	32ch	8ch		
EVA100-E1-M27	8ch	30ch	-	_	32ch	_		
EVA100-E1-M33	8ch	12ch	2ch	4ch	32ch	4ch		

Power source cable

Model Number	Plug Type
EVA100-ACCBL-01	PSE/UL/CSA
EVA100-ACCBL-02	CEE
EVA100-ACCBL-03	CCC
EVA100-ACCBL-04	EU-SEV
EVA100-ACCBL-05	UK

Other accessories

Model Number	
EVA100-PB-0101	Additional General PB
R16904	Wheeled rack

• Basic system configuration: mainframe, ACDC box, connection cable, General PB, General PB cover, software suite, operating manual.

Power source cable is not included in basic system configuration. Please select the appropriate cable from the list above.

•All specifications and images in this catalog are correct at the time of publication, but may change without notice. Please contact us to ensure you have the most up-to-date information on our products and services.



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